



# FCC&ISED RF Test Report

**Product Name: Smart Phone** 

**Model Number: EML-L09** 

Report No.: SYBH(Z-RF) 20181128006001-2001

FCC ID: QISEML-L09 IC: 6369A-EMLL09

Autheorized	APPROVED	PREPARED		
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DATE	2018-12-26	2018-12-26		

# Reliability Laboratory of Huawei Technologies Co., Ltd.

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# **\* \* Notice \* \***

- 1. The Reliability Laboratory of Huawei Technologies Co., Ltd has passed the accreditation by The American Association for Laboratory Accreditation (A2LA). The accreditation number is 2174.01
- 2. The Laboratory of Sporton International (Shenzhen) Inc has passed the accreditation by National Voluntary Laboratory Accreditation Program (NVLAP). The NVLAP LAB CODE is 600156-0.
- 3. The Reliability Laboratory of Huawei Technologies Co., Ltd has been recognized by the US Federal Communications Commission (FCC) to perform compliance testing subject to the Commission's Certification rules. The Designation Number is CN1173, and the Test Firm Registration Number is 294140.
- 4. The Laboratory of Sporton International (Shenzhen) Inc has been recognized by the US Federal Communications Commission (FCC) to perform compliance testing subject to the Commission's Certification rules. The Designation Number is CN5019, and the Test Firm Registration Number is 577730.
- 5. The Reliability Laboratory of Huawei Technologies Co., Ltd has been listed by Industry Canada to perform electromagnetic emission measurements. The recognition numbers of test site are 6369A-1.
- 6. The Reliability Laboratory of Huawei Technologies Co., Ltd is also named "Global Compliance and Testing Center of Huawei Technologies Co., Ltd", the both names have coexisted since 2009.
- 7. The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- 8. The test report is invalid if there is any evidence of erasure and/or falsification.
- 9. The test report is only valid for the test samples.
- 10. Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.

# **MODIFICATION RECORD**

Ν	Report No	Modification Description	Testing
0			Period
1	SYBH(Z-RF)2018013	First release.	2018.1.2~20
	1016001		18.2.5
2	SYBH(Z-RF)	Updated report:	2018.12.6~2
	20181128006001-200	(1) Updated the version of the board, and added some tests	018.12.26
	1	according to differences and modifications of the new version,	
		please see General Description for details:	
		Note 1:	

## **DECLARATION**

Туре	Description
Multiple	
Models	☐ The present report applies to several models. The practical measurements are
Applications	performed with the model
	These models utilize the similar radio design, shielding, interface, physical layout and so on. The differences and modifications between these models are declared by the applicant and showed in General Description  All others between these models are identical.  The present report only presents the worst test case of all modes, see relevant test results for detailed.



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## 2 **General Information**

#### 2.1 Test standard/s

	47 CFR FCC Part 02
	47 CFR FCC Part 24
	47 CFR FCC Part 27
Applied Rules :	ISED RSS-Gen Issue 5,
	ISED RSS-133 Issue 6,
	ISED RSS-199 Issue 3
Took Makhadi.	FCC KDB 971168 D01 Power Meas License Digital Systems v03r01
Test Method :	ANSI C63.26

#### 2.2 Test Environment

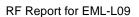
Temperature :	TN 19.5 to 25 °C during room temperature tests		uring room temperature tests	
Ambient Relative Humidity:	40 to	55 %		
Atmospheric Pressure:	Not app	licable		
	VL	3.6	V	
Power supply :	VN	3.82	V	DC by Battery
	VH	4.35	V	

NOTE: 1) VN= nominal voltage, VL= low extreme test voltage, VH= High extreme test voltage;

TN= normal temperature, TL= low extreme test temperature, TH= High extreme test temperature.

#### 2.3 Test Laboratories

Test Location 1 :	RELIABILITY LABORATORY OF HUAWEI TECHNOLOGIES CO., LTD.			
Address of Test	No.2 New City Avenue Songshan Lake Sci. &Tech. Industry Park, Dongguan,			
Location 1:	Guangdong, P.R.C			
Sub-contracted Test	Charten International (Chanthan) Inc			
Location 1:	Sporton International (Shenzhen) Inc.			
Address of	No 2 Building the third floor of courts Chaha Diversusest Fonggovuon			
Sub-contracted Test	No.3 Building, the third floor of south, Shahe River west, Fengzeyuan warehouse, Nanshan District, Shenzhen, Guangdong, P.R.China			
Location 1:	wateriouse, Natistian District, Shenzhen, Guanguong, P.R.China			



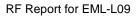


# 2.4 Applicant and Manufacturer

Company Name : HUAWEI TECHNOLOGIES CO., LTD			
Address :	Administration Building, Headquarters of Huawei Technologies Co., Ltd.,		
Address .	Bantian, Longgang District, Shenzhen, 518129, P.R.C		

# 2.5 Application details

Date of Receipt Sample:	2018-12-03
Start of test:	2018-12-06
End of test:	2018-12-26





# 3 Test Summary

# 3.1 PCS Band CA\_2C(1850-1910 MHz paired with 1930-1990 MHz)

Test Item	FCC	ISED Rule	Requirements	Test	Verdict	Testing
rest item	Rule No.	No.	requirements	Result	(Note1)	location
Effective (Isotropic) Radiated Power Output Data	§2.1046, §24.232	RSS-Gen, §6.12; RSS-133, §6.4	EIRP ≤ 2 W	Appendix A	Pass	Test Location 1
Peak-Average	§2.1046,	RSS-133,		Appendix	_	Test Location 1
Ratio	§24.232	§6.4	Limit≤13 dB	В	Pass	
Modulation Characteristics	§2.1047	RSS-133, §6.2	Digital modulation	Appendix C	Pass	Test Location 1
Bandwidth	§2.1049	RSS-Gen, §6.7	OBW: No limit. EBW: No limit.	Appendix D	Pass	Test Location 1
Band Edges Compliance	§2.1051, §24.238	RSS-Gen, §6.13; RSS-133, §6.5	FCC:≤ -13 dBm/1%*EBW, in  1 MHz bands immediately outside and adjacent to the frequency block.  Note 1): EBW is -26 dBc EBW.  ISED: ≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.  Note 1): EBW is -20 dBc EBW, or OBW.	Appendix E	Pass	Test Location 1
Spurious Emission at Antenna Terminals	§2.1051, §24.238	RSS-Gen, §6.13; RSS-133, §6.5	FCC: ≤ -13 dBm/1 MHz, from max( lowest internal frequency, 9 kHz ) to min( 10 * highest fundamental frequency, 40 GHz) but outside authorized operating frequency blocks.  ISED: ≤ -13 dBm/1 MHz, from max( min( lowest internal frequency, 30 MHz ), 9 kHz ) to min( 10 * highest fundamental frequency, 40	Appendix F	Pass	Test Location 1



Test Item	FCC	ISED Rule	Doguiromente	Test	Verdict	Testing	
rest item	Rule No.	No.	Requirements	Result	(Note1)	location	
			GHz) but outside authorized				
			operating frequency blocks.				
			FCC: ≤ -13 dBm/1 MHz, from			Test Location	
			max( lowest internal			1(above	
			frequency, 9 kHz ) to min( 10			30MHz);&	
			* highest fundamental			Sub-contracted	
			frequency, 40 GHz) but			Test Location	
		RSS-Gen,	outside authorized operating			1(9K-30MHz)	
Field Strength	§2.1053,	·	frequency blocks.	Annondiv			
of Spurious		§6.13;		Appendix	Pass		
Radiation	§24.238	RSS-133,	ISED: ≤ -13 dBm/1 MHz,	G			
		§6.5	from max( min( lowest				
			internal frequency, 30 MHz),				
			9 kHz ) to min( 10 * highest				
			fundamental frequency, 40				
			GHz) but outside authorized				
			operating frequency blocks.				
		RSS-Gen,	FCC:Within authorized			Test Location 1	
	\$0.4055	,	bands of operation/frequency	A m m a m alise			
Frequency	§2.1055,	§6.11	block.	Appendix	Pass		
Stability	§24.235	RSS-133,		Н			
		§6.3	ISED≤ ±2.5 ppm				
NOTE: For the							

# 3.2 BRS&EBS Band CA\_7C (2500-2570 MHz paired with 2620-2690 MHz)

Test Item	FCC Rule No.	ISED Rule No.	Requirements	Test Result	Verdict (Note1)	Testing location
Effective (Isotropic) Radiated Power Output Data	§2.1046, §27.50(h)	RSS-Gen, §6.12; RSS-199, §4.4	EIRP ≤ 2W	Appendix A	Pass	Test Location 1
Peak-Average Ratio	§27.50(a)	RSS-199, §4.4	Limit≤13 dB	Appendix B	Pass	Test Location 1
Modulation Characteristics	§2.1047	RSS-199, §4.1	Digital modulation	Appendix C	Pass	Test Location 1
Bandwidth	§2.1049	RSS-Gen, §6.7	OBW: No limit. EBW: No limit.	Appendix D	Pass	Test Location 1
Band Edges Compliance	§2.1051, §27.53(m4)	RSS-Gen, §6.13;	FCC:	Appendix E	Pass	Test Location 1

Test Item	FCC Rule No.	ISED Rule No.	Requirements	Test Result	Verdict (Note1)	Testing location
		RSS-199, §4.5; RSS-199, §4.2	-10 dBm/ MHz			
Spurious Emission at Antenna Terminals	§2.1051, §27.53(m)	RSS-Gen, §6.13; RSS-199, §4.5; RSS-199, §4.2	Note 1): EBW is -26 dBc EBW.  Note 2): MeasFrom: max( lowest internal frequency, 9 kHz ).  Note 3): MeasTo: min( 10 * highest fundamental frequency, 40 GHz).	Appendix F	Pass	Test Location 1



Test Item	FCC Rule No.	ISED Rule No.	Requirements	Test Result	Verdict (Note1)	Testing location
			ISED:  Channel Edge  25 dBm/ 1 MHz  Fa			
Field Strength of Spurious Radiation	§2.1053, §27.53(m)	RSS-Gen, §6.13; RSS-199, §4.5	FCC:  Channel Edge 25 dBm/ 1 MHz 1 M	Appendix G	Pass	Test Location 1(above 30MHz);& Sub-contracted Test Location 1(9K-30MHz)

Test Item	FCC Rule No.	ISED Rule No.	Requirements	Test Result	Verdict (Note1)	Testing location						
			AND  AND  AND  AND  AND  AND  AND  AND									
Fraguenes	\$2.10EE	RSS-Gen,	Within authorized bands of	Appondix		Test Location 1						
Frequency Stability	§2.1055, §27.54	§6.11; RSS-199,	operation/frequency block.	Appendix H	Pass							
Otability	321.0∓	§4.3	operation/mequency block.	11								
NOTE: For the	he verdict, the	"N/A" denote	s "not applicable", the "N/T" denotes "no	ot tested".								

# 3.3 BRS&EBS Band CA\_38C (2570-2620 MHz paired with 2570-2620 MHz)

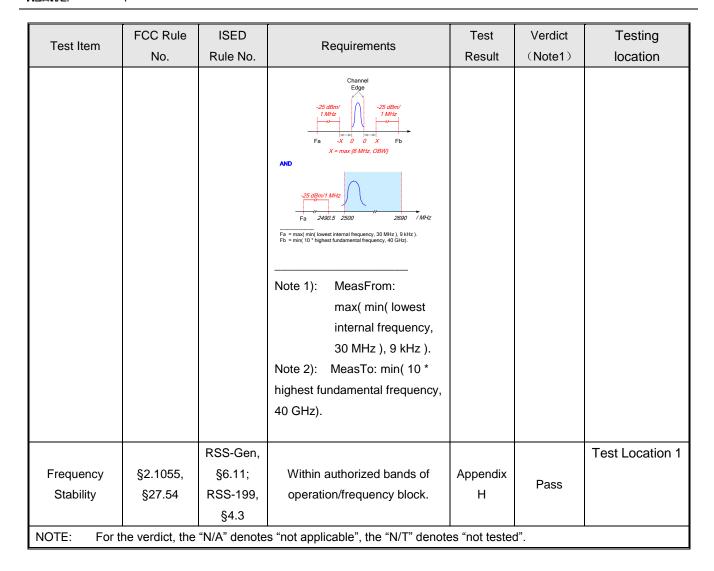
Took Itoms	FCC Rule	ISED	Do muino monto	Test	Verdict	Testing
Test Item	No.	Rule No.	Requirements	Result	(Note1)	location
Effective (Isotropic)	§2.1046,	RSS-Gen, §6.12;		Appendix		
Radiated Power Output Data	§27.50(h)	RSS-199, §4.4	EIRP ≤ 2W	А	Pass	Test Location 1
Peak-Average Ratio	§27.50(a)	RSS-199, §4.4	Limit≤13 dB	Appendix B	Pass	Test Location 1
Modulation Characteristics	§2.1047	RSS-199, §4.1	Digital modulation	Appendix C	Pass	Test Location 1
Bandwidth	§2.1049	RSS-Gen, §6.7	OBW: No limit. EBW: No limit.	Appendix D	Pass	Test Location 1
Band Edges	§2.1051,	RSS-Gen, §6.13;	F00.	Appendix	Dana	Test Location 1
Compliance	§27.53(m4)	RSS-199, §4.5;	FCC:	E	Pass	



Test Item	FCC Rule	ISED	Requirements	Test	Verdict	Testing
1 GOL ILGIII	No.	Rule No.		Result	(Note1)	location
		RSS-199, §4.2	-10 dBm/1 MHz -13 dBm/1 MHz -13 dBm/1 MHz -13 dBm/1 MHz -14 dBm/1 MHz -15 dBm/1 MHz -16 dBm/1 MHz -17 dBm/1 MHz -18 dBm/1 MHz -19 dBm/1 MHz -19 dBm/1 MHz -19 dBm/1 MHz -10 dBm/1 MHz			
Spurious Emission at Antenna Terminals	§2.1051, §27.53(m)	RSS-Gen, §6.13; RSS-199, §4.5; RSS-199, §4.2	Note 1): EBW is -26 dBc EBW.  Note 2): MeasFrom: max( lowest internal frequency, 9 kHz).  Note 3): MeasTo: min( 10 * highest fundamental frequency, 40 GHz).  ISED:	Appendix F	Pass	Test Location 1



Test Item	FCC Rule No.	ISED Rule No.	Requirements	Test Result	Verdict (Note1)	Testing location
			AND  AND  AND  AND  AND  AND  AND  AND			
Field Strength of Spurious Radiation	§2.1053, §27.53(m)	RSS-Gen, §6.13; RSS-199, §4.5	AND  Channel Edge  25 dBm/ 1 MHz  Fa = max (6 MHz, EBW)  AND  AND  AND  AND  AND  AND  AND  AN	Appendix G	Pass	Test Location 1(above 30MHz);& Sub-contracted Test Location 1(9K-30MHz)



## 3.4 Band CA\_41C (2545-2655 MHz paired with 2545-2655 MHz)

Took Itoms	FCC Rule	ISED	Descriperante	Test	Verdict	Testing
Test Item	No.	Rule No.	Requirements	Result	(Note1)	location
Effective (Isotropic) Radiated	§2.1046,	RSS-Gen, §6.12;	EIRP ≤ 2W	Appendix	Pass	Test Location 1
Power Output  Data	§27.50(h)	RSS-199, §4.4	LINF 3 ZVV	А	r a55	Test Location 1
Peak-Average Ratio	§27.50(a)	RSS-199, §4.4	Limit≤13 dB	Appendix B	Pass	Test Location 1
Modulation Characteristics	§2.1047	RSS-199, §4.1	Digital modulation	Appendix C	Pass	Test Location 1
Bandwidth	§2.1049	RSS-Gen, §6.7	OBW: No limit. EBW: No limit.	Appendix D	Pass	Test Location 1
		RSS-Gen,				Test Location 1
Band Edges Compliance	§2.1051, §27.53(m4)	§6.13; RSS-199, §4.5;	FCC:	Appendix E	Pass	

Test Item	FCC Rule	ISED Bula Na	Requirements	Test	Verdict	Testing
	No.	Rule No.  RSS-199, §4.2	-10 dBm/1 MHz -10 dBm/1 MHz -13 dBm/1 MHz -13 dBm/1 MHz -13 dBm/1 MHz -13 dBm/1 MHz -14 dBm/1 MHz -15 dBm/1 MHz -16 dBm/1 MHz -17 dBm/1 MHz -18 dBm/1 MHz -18 dBm/1 MHz -19 dBm/1 MHz -19 dBm/1 MHz -10 dBm/1 MHz	Result	(Note1)	location
Spurious Emission at Antenna Terminals	§2.1051, §27.53(m)	RSS-Gen, §6.13; RSS-199, §4.5; RSS-199, §4.2	Note 1): EBW is -26 dBc EBW.  Note 2): MeasFrom: max( lowest internal frequency, 9 kHz ).  Note 3): MeasTo: min( 10 * highest fundamental frequency, 40 GHz).  ISED:	Appendix F	Pass	Test Location 1



Test Item	FCC Rule No.	ISED Rule No.	Requirements	Test Result	Verdict (Note1)	Testing location
			AND  AND  AND  AND  AND  AND  AND  AND			
Field Strength of Spurious Radiation	§2.1053, §27.53(m)	RSS-Gen, §6.13; RSS-199, §4.5	AND  Channel Edge  25 dBm/ 1 MHz  Fa = max (6 MHz, EBW)  AND  AND  AND  AND  AND  AND  AND  AN	Appendix G	Pass	Test Location 1(above 30MHz);& Sub-contracted Test Location 1(9K-30MHz)

	FCC Rule	ISED		Toot	Verdict	Tooting	
Test Item			Requirements	Test		Testing	
	No.	Rule No.		Result	(Note1)	location	
			Channel Edge  25 dBm/ 1 MHz  Fa				
		RSS-Gen,				Test Location 1	
Frequency	§2.1055,	§6.11;	Within authorized bands of	Appendix	Pass		
Stability	§27.54	RSS-199,	operation/frequency block.	Н	1 400		
		§4.3					
NOTE: For the	NOTE: For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".						



#### 4 Description of the Equipment under Test (EUT)

## 4.1 General Description

EML-L09 is subscriber equipment in the LTE/ WCDMA/GSM system. The LTE frequency band for Single Carrier is Band 1, Band 2, Band 3, Band 4, Band 5, Band 6, Band 7, Band 8, Band 9, Band 12, Band17, Band 18, Band 19, Band 20, Band 26, Band 28, Band 32, Band 34, Band 38, Band39, Band 40 and Band 41 and the LTE frequency band for Intra-band carrier aggregation uplink operation band is CA\_1C, CA\_2C, CA\_3C, CA\_7C, CA\_38C, CA\_39C, CA\_41C. The HSUPA/HSDPA/UMTS frequency band is Band I, Band II, Band IV, Band V, Band VI, Band VIII and Band XIX. The GSM/GPRS/EDGE frequency band includes GSM850 and GSM900 and DCS1800 and PCS1900. The Mobile Phone implements such functions as RF signal receiving/transmitting, LTE/ WCDMA /GSM protocol processing, voice, video, MMS service, GPS ,NFC and WIFI etc. Externally it provides earphone port (to provide voice service) and single USIM card interfaces. It also provides Bluetooth module to synchronize data between a PC and the phone, or to use the built-in modem of the phone to access the Internet with a PC, or to exchange data with other Bluetooth devices.

#### The changed points:

Item	The detail software changed points
Supported uplink CA	New add to support CA_2C, CA_7C, CA_38C,CA_41C

The mobile phone EML-L29 and EML-L09 are LTE/UMTS/GSM mobile phone with Bluetooth. The differences between EML-L29 and EML-L09 are showed in the following table. EML-L09 delete one SIM by software. Other parts of the mobile phone are the same, including the appearance, the antenna, Chipset, Bluetooth mode, Wifi mode, Adapter, Battery, and so on.

	EML-L29	EML-L09
GSM four bands	B2/B3/B5/B8	B2/B3/B5/B8
WCDMA bands	B1/2/4/5/6/8/19	B1/2/4/5/6/8/19
LTE bands	FDD LTE:	FDD LTE:
	B1/2/3/4/5/6/7/8/9/12/17/18/19/20/	B1/2/3/4/5/6/7/8/9/12/17/18/19/20/
	B26/28/32, CA_1C, CA_2C, CA_3C,	B26/28/32, CA_1C, CA_2C, CA_3C,
	CA_7C	CA_7C
	TDD LTE: B34/B38/39/40/41	TDD LTE: B34/B38/39/40/41
	(110M,2545-2655), CA_38C, CA_39C,	(110M,2545-2655), CA_38C, CA_39C,
	CA_41C	CA_41C
FCC bands	GSM850/1900	GSM850/1900
	WB2/B4/B5	WB2/B4/B5
	LTE	LTE



	B2/4/5/B7/B12/B17/B26/38/B41,	B2/4/5/B7/B12/B17/B26/38/B41,
	CA_2C, CA_7C, CA_38C, CA_41C	CA_2C, CA_7C, CA_38C, CA_41C
SIM card	Two	One
NFC	the same	the same
External camera	the same	the same
internal camera	the same	the same
FLASH	the same	the same
Mainboard	the same	the same
PCB layout	the same	the same
Appearance	the same	the same
Bluetooth mode	the same	the same
WLAN mode	the same	the same
BT/ WLAN antenna	the same	the same
GSM/ WCDMA /LTE	the same	the same
antenna		
Adapter	the same	the same
Battery	the same	the same
Chipset	the same	the same
Memory	the same	the same
RF Parameter	The same RF Parameter in the same	The same RF Parameter in the same
	band	band
Dimension	the same	the same
Main Frequency NV	The same NV in the same band	The same NV in the same band

#### So

NOTE1: Only LTE Band CA\_2C, CA\_7C, CA\_38C, CA\_41C data included in this report and the others can refer to No.SYBH(Z-RF)20180131016001) of EML-L09(FCC ID: QISEML-L09&IC: 6369A-EMLL09) history report

NOTE2: We do not test LTE Band CA\_2C, CA\_7C, CA\_38C, CA\_41C of EML-L09, the test data refer to No. SYBH(Z-RF)20181114005001-2001 of EML-L29(FCC ID: QISEML-L29 & IC: 6369A-EMLL29) report

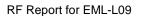
#### 4.2 EUT Identity

NOTE:

Unless otherwise noted in the report, the functional boards installed in the units shall be selected from the below list, but not means all the functional boards listed below shall be installed in one unit.

#### 4.2.1 **Board**

Board							
Description	Software Version	Hardware Version					
Main Board	EML-L09 8.1.0.178(C900)	HL1EMILYM					

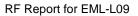




# 4.2.2 Sub-Assembly

		Sub-Ass	embly
Sub-Assembly Name	Model	Manufacturer	Description
Adapter	HW-050450B00	Huawei Technologies Co.,Ltd.	Input Voltage:100V-240V~50/60Hz, 0.75A  Output Voltage: 5V === 2A/4.5A; 4.5V 5A
Adapter	HW-050450E00	Huawei Technologies Co.,Ltd.	Input Voltage:100V-240V~50/60Hz, 0.75A Output Voltage: 5V === 2A/4.5A; 4.5V 5A
Adapter	HW-050450U00	Huawei Technologies Co.,Ltd.	Input Voltage:100V-240V~50/60Hz, 0.75A  Output Voltage: 5V === 2A/4.5A; 4.5V 5A
Adapter	HW-050450A00	Huawei Technologies Co.,Ltd.	Input Voltage:100V-240V~50/60Hz, 0.75A Output Voltage: 5V === 2A/4.5A; 4.5V 5A
Rechargeable Li-ion	HB396285ECW	Huawei Technologies Co.,Ltd.	Rated capacity: 3320mAh Nominal Voltage: +3.82V Charging Voltage: +4.4V

Report No.: SYBH(Z-RF) 20181128006001-2001





# 4.3 Technical Specification

NOTE: For the detailed technical descriptions, see the applicant/manufacturer's specifications or user manual.

#### 4.3.1 General

Characteristics	Description						
Radio System Type							
Supported Frequency Range	CA Bond CA 2C	Transmission (TX): 1850 to 1910 MHz					
	CA_Band_CA_2C	Receiving (RX): 1930 to 1990 MHz					
	CA Bond CA 70	Transmission (TX): 2500 to 2570 MHz					
	CA_Band_CA_7C	Receiving (RX): 2620 to 2690 MHz					
	CA Bond CA 20C	Transmission (TX): 2750 to 2620 MHz					
	CA_Band_CA_38C	Receiving (RX): 2570 to 2620 MHz					
	CA Bond CA 41C	Transmission (TX): 2545 to 2655 MHz					
	CA_Band_CA_41C	Receiving (RX): 2545 to 2655 MHz					
TX and RX Antenna Ports	TX & RX port:	1					
(one band)	TX-only port:	0					
	RX-only port:	1					
Target TX Output Power	LTE BAND CA_2C:	23dBm					
	LTE BAND CA_7C:	22.8dBm					
	LTE BAND CA_38C: 22.8dBm						
	LTE BAND CA_41C: 23dBm						
Supported Channel Bandwidth	CA_Band_CA_2C	⊠5MHz+20MHz, ⊠10MHz+15MHz, ⊠					
		10MHz+20MHz, ⊠15MHz+15MHz, ⊠15MHz+20MHz,					
		⊠20MHz+20MHz,					
	CA_Band_CA_7C	⊠10MHz+20MHz, ⊠15MHz+15MHz, ⊠					
		15MHz+20MHz,⊠20MHz+20MHz,					
	CA_Band_CA_38C	⊠15MHz+15MHz, 20MHz+20MHz,					
	CA_Band_CA_41C	⊠5MHz+20MHz, ⊠10MHz+20MHz, ⊠					
		15MHz+15MHz,⊠20MHz+20MHz,					
Designation of Emissions	LTE BAN CA_2C:	23M6G7D (20+5 MHz QPSK modulation),					
(Note: the necessary bandwidth of		23M5W7D (20+5 MHz 16QAM modulation)					
which is the worst value from the		38M5G7D (20+20 MHz QPSK modulation),					
measured occupied bandwidths for		38M4W7D (20+20 MHz 16QAM modulation)					
each type of channel bandwidth	LTE BAND CA_7C:	29M1G7D (15+15 MHz QPSK modulation),					
configuration.)		29M0W7D (15+15 MHz 16QAM modulation)					
		38M6G7D (20+20 MHz QPSK modulation),					
		38M6W7D (20+20 MHz 16QAM modulation)					
	LTE BAND	29M1G7D (15+15 MHz QPSK modulation),					
	CA_38C:	29M1W7D (15+15 MHz 16QAM modulation)					
		38M6G7D (20+20 MHz QPSK modulation),					



Characteristics	Description					
		38M6W7D (20+20 MHz 16QAM modulation)				
	LTE BAND	29M0G7D (15+15 MHz QPSK modulation),				
	CA_41C:	29M0W7D (15+15 MHz 16QAM modulation)				
		38M5G7D (20+20 MHz QPSK modulation),				
		38M5W7D (20+20 MHz 16QAM modulation)				

## 5 General Test Conditions / Configurations

#### 5.1 Test Modes

NOTE1: The test mode(s) are selected according to relevant radio technology specifications.

NOTE2: The power of LTE system 64QAM modulation is lower than that of 16QAM, so we did not test

64QAM modulation.

Test Mode	Test Modes Description			
LTE/TM1	LTE system, QPSK modulation			
LTE/TM2 LTE system, 16QAM modulation				



# 5.2 Test Frequency

Test frequencies for CA_2C													
	CC-Combo CC1								CC2				
Danas	/	Note1						Note1					
Range	N <sub>RB_agg</sub>	BW	Nul	fuL	NDL	foL	BW	Nul	fuL	NDL	foL		
	[RB]	[RB]		[MHz]		[MHz]	[RB]		[MHz]		[MHz]		
	25 , 100	25	18633	1853.3	633	1933.3	100	18750	1865	750	1945		
	25+100	100	18700	1860	700	1940	25	18817	1871.7	817	1951.7		
	E0.7E	50	18653	1855.3	653	1935.3	75	18773	1867.3	773	1947.3		
	50+75	75	18675	1857.5	675	1937.5	50	18795	1869.5	795	1949.5		
Law	F0 : 400	50	18655	1855.5	655	1935.5	100	18799	1869.9	799	1949.9		
Low	50+100	100	18700	1860	700	1940	50	18844	1874.4	844	1954.4		
	75+75	75	18675	1857.5	675	1937.5	75	18825	1872.5	825	1952.5		
	75 : 400	75	18678	1857.8	678	1937.8	100	18849	1874.9	849	1954.9		
	75+100	100	18700	1860	700	1940	75	18871	1877.1	871	1957.1		
	100+100	100	18700	1860	700	1940	100	18898	1879.8	898	1959.8		
	25+100	25	18808	1870.8	808	1950.8	100	18925	1882.5	925	1962.5		
		100	18875	1877.5	875	1957.5	25	18992	1889.2	992	1969.2		
	50+75	50	18829	1872.9	829	1952.9	75	18949	1884.9	949	1964.9		
		75	18851	1875.1	851	1955.1	50	18971	1887.1	971	1967.1		
B 41: 1	50+100	50	18806	1870.6	806	1950.6	100	18950	1885	950	1965		
Mid		100	18851	1875.1	851	1955.1	50	18995	1889.5	995	1969.5		
	75+75	75	18825	1872.5	825	1952.5	75	18975	1887.5	975	1967.5		
	75 . 400	75	18803	1870.3	803	1950.3	100	18974	1887.4	974	1967.4		
	75+100	100	18826	1872.6	826	1952.6	75	18997	1889.7	997	1969.7		
	100+100	100	18801	1870.1	801	1950.1	100	18999	1889.9	999	1969.9		
	05.400	25	18983	1888.3	983	1968.3	100	19100	1900	1100	1980		
	25+100	100	19050	1895	1050	1975	25	19167	1906.7	1167	1986.7		
	50.75	50	19005	1890.5	1005	1970.5	75	19125	1902.5	1125	1982.5		
	50+75	75	19027	1892.7	1027	1972.7	50	19147	1904.7	1147	1984.7		
1.12.1	50.400	50	18956	1885.6	956	1965.6	100	19100	1900	1100	1980		
High	50+100	100	19001	1890.1	1001	1970.1	50	19145	1904.5	1145	1984.5		
	75+75	75	18975	1887.5	975	1967.5	75	19125	1902.5	1125	1982.5		
	75.400	75	18929	1882.9	929	1962.9	100	19100	1900	1100	1980		
	75+100	100	18951	1885.1	951	1965.1	75	19122	1902.2	1122	1982.2		
	100+100	100	18902	1880.2	902	1960.2	100	19100	1900	1100	1980		
Note 1:	Carriers in in	creasir	ng freque	ncy order.		-		•	-				

Test frequencies for CA\_7C

	CC-Combo			CC1			CC2				
Dongs	1			Note1			Note1				
Range	N <sub>RB_agg</sub>	BW	NuL	fuL	NDL	foL	BW	Nul	fuL	NDL	foL
	[RB]	[RB]		[MHz]		[MHz]	[RB]		[MHz]		[MHz]
	50+100	50	20805	2505.5	2805	2625.5	100	20949	2519.9	2949	2639.9
	30+100	100	20850	2510	2850	2630	50	20994	2524.4	2994	2644.4
Low	75+75	75	20825	2507.5	2825	2627.5	75	20975	2522.5	2975	2642.5
Low	75+100	75	20828	2507.8	2828	2627.8	100	20999	2524.9	2999	2644.9
	75+100	100	20850	2510	2850	2630	75	21021	2527.1	3021	2647.1
	100+100	100	20850	2510	2850	2630	100	21048	2529.8	3048	2649.8
	50+100	50	21006	2525.6	3006	2645.6	100	21150	2540	3150	2660
		100	21051	2530.1	3051	2650.1	50	21195	2544.5	3195	2664.5
NA: al	75+75	75	21025	2527.5	3025	2647.5	75	21175	2542.5	3175	2662.5
Mid	75 : 400	75	21003	2525.3	3003	2645.3	100	21174	2542.4	3174	2662.4
	75+100	100	21026	2527.6	3026	2647.6	75	21197	2544.7	3197	2664.7
	100+100	100	21001	2525.1	3001	2645.1	100	21199	2544.9	3199	2664.9
	F0 : 400	50	21206	2545.6	3206	2665.6	100	21350	2560	3350	2680
	50+100	100	21251	2550.1	3251	2670.1	50	21395	2564.5	3395	2684.5
Lliab	75+75	75	21225	2547.5	3225	2667.5	75	21375	2562.5	3375	2682.5
High	75+100	75	21179	2542.9	3179	2662.9	100	21350	2560	3350	2680
	75+100	100	21201	2545.1	3201	2665.1	75	21372	2562.2	3372	2682.2
	100+100	100	21152	2540.2	3152	2660.2	100	21350	2560	3350	2680
Note 1:	Carriers in in	creasir	ng fregue	ncv order							

	Test frequencies for CA_38C								
	CC-Combo		CC1		CC2				
Pango	/		Note1			Note1			
Range	N <sub>RB_agg</sub>	BW	Nul/dl	ful/DL	BW	Nul/dl	ful/DL		
	[RB]	[RB]	INUL/DL	[MHz]	[RB]	INUL/DL	[MHz]		
Law	75+75	75	37825	2577.5	75	37975	2592.5		
Low	100+100	100	37850	2580	100	38048	2599.8		
Mid	75+75	75	37925	2587.5	75	38075	2602.5		
IVIIG	100+100	100	37901	2585.1	100	38099	2604.9		
Lligh	75+75	75	38025	2597.5	75	38175	2612.5		
High	100+100	100	37952	2590.2	100	38150	2610		
Note 1: Car	riers in increasing f	requency	order.		·				

Test frequencies for CA_41C(2545-2655)								
	CC-Combo		CC2					
Dongo	1		Note1		Note1			
Range	N <sub>RB_agg</sub>	BW	Ni	ful/DL	BW	N	ful/DL	
	[RB]	[RB]	<b>N</b> ul/dl	[MHz]	[RB]	Nul/dl	[MHz]	
Low	25+100	25	40173	2548.3	100	40290	2560	



		Test free	quencies for C	A_41C(2545-2	2655)			
Dongo	CC-Combo		CC1		CC2			
Range	1		Note1			Note1		
		100	40240	2555	25	40357	2566.7	
	F0 : 100	50	40195	2550.5	100	40339	2564.9	
	50+100	100	40240	2555	50	40384	2569.4	
	75+75	75	40215	2552.5	75	40365	2567.5	
	75 : 100	75	40218	2552.8	100	40389	2569.9	
	75+100	100	40240	2555	75	40411	2572.1	
	100+100	100	40240	2555	100	40438	2574.8	
	25 : 100	25	40598	2590.8	100	40715	2602.5	
	25+100	100	40665	2597.5	25	40782	2609.2	
	50+100	50	40596	2590.6	100	40740	2605	
		100	40641	2595.1	50	40785	2609.5	
Mid	75+75	75	40615	2592.5	75	40765	2607.5	
	75 : 400	75	40593	2590.3	100	40764	2607.4	
	75+100	100	40616	2592.6	75	40787	2609.7	
	100+100	100	41011	2632.1	100	40719	2602.9	
	05.400	25	41023	2633.3	100	41140	2645	
	25+100	100	41090	2640	25	41207	2651.7	
	50.400	50	40996	2630.6	100	41140	2645	
I II ada	50+100	100	41041	2635.1	50	41185	2649.5	
High	75+75	75	41015	2632.5	75	41165	2647.5	
	75 : 100	75	40969	2627.9	100	41140	2645	
	75+100	100	40991	2630.1	75	41162	2647.2	
	100+100	100	40942	2625.2	100	41140	2645	



#### 5.3 DESCRIPTION OF TESTS

#### 5.3.1 Radiated Power and Radiated Spurious Emissions

Radiated spurious emissions are investigated indoors in a full-anechoic chamber to determine the frequencies producing the worst case emissions. Final measurements for radiated power and radiated spurious emissions are performed on the 3 meter OATS per the guidelines of ANSI/TIA-603-E-2016. The equipment under test was transmitting while connected to its integral antenna and is placed on a wooden turntable 150cm above the ground plane and 3 meters from the receive antenna. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Emissions are also investigated with the receive antenna horizontally and vertically polarized.

A portable or small unlicensed wireless device shall be placed on a non-metallic test fixture or other non-metallic support during testing. The supporting fixture shall permit orientation of the EUT in each of three orthogonal (x, y, z) axis positions such that emissions from the EUT are maximized. Measure the EUT maximum RF power and record the result.

A half-wave dipole is then substituted in place of the EUT. For emissions above 3GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT.

The power of the emission is calculated using the following formula:

Pd [dBm] = Pg [dBm] - cable loss [dB] + antenna gain [dBd/dBi]

Where, P<sub>d</sub> is the dipole equivalent power, P<sub>g</sub> is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to Pg [dBm] – cable loss [dB].

The calculated Pd levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of 43 + 10log<sub>10</sub>(Power [Watts]).

#### **Test Procedures Used**

KDB 971168 D01 v03-Section 5

ANSI/TIA-603-E-2016-Section 2.2.17 / ANSI/TIA-603-E-2016-Section 2.2.12

Note: Reference test setup 3



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## 5.3.2 Peak-Average Ratio

A peak to average ratio measurement is performed at the conducted port of the EUT. The spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth.

#### **Test Procedures Used**

KDB 971168 D01 v03-Section 5.7.2

#### **Test Settings**

- 1. The signal analyzer's CCDF measurement profile enabled
- 2. Frequency= carrier center frequency
- 3. Measurement BW > EBW of signal
- 4, for continuous transmissions, set to 1ms
- 5. Record the maximum PAPR level associated with a probability of 0.1%.

Note: Reference test setup 1



#### 5.3.3 Occupied Bandwidth

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

## **Test Procedures Used**

KDB 971168 D01 v03-Section 4.3

#### **Test Settings**

- 1、SET RBW=1-5% of OBW
- 2、SET VBW ≥ 3\*RBW
- 3. Detector: Peak
- 4. Trace mode= max hold.
- 5. Sweep= auto couple
- 6. Steps 1-5 were repeated after it is stable

Note: Reference test setup 1.

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**Public** 

5.3.4 **Band Edge Compliance** 

The test complies with the requirements in clause 2 of the present report according to test procedures in

KDB 971168 D01 v03-Section 6 with corresponding test settings.

Note: Reference test setup 1.

5.3.5 **Spurious and Harmonic Emissions at Antenna Terminal** 

The test complies with the requirements in clause 2 of the present report according to test procedures in

KDB 971168 D01 v03-Section 6 with corresponding test settings.

Note: Reference test setup 1.

5.3.6 Frequency Stability / Temperature Variation

Frequency stability testing is performed in accordance with the guidelines of ANSI/TIA-603-E-2016. The

frequency stability of the transmitter is measured by:

a.) Temperature: The temperature is varied from -30°C to +50°C in 10°C increments using an

environmental chamber.

b.) Primary Supply Voltage: The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment,

primary supply voltage is reduced to the battery operating end point which shall be specified by the

manufacturer.

Specification - The frequency stability shall be sufficient to ensure that the fundamental emission stays

within the authorized frequency block. The frequency stability of the transmitter shall be maintained within

±0.00025% (±2.5 ppm) of the center frequency.

**Time Period and Procedure:** 

1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).

2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the

transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after

applying power to the transmitter.

3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least

one half-hour is provided to allow stabilization of the equipment at each temperature level.

**Test Procedures Used** 

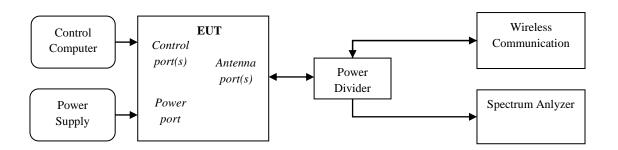
ANSI/TIA-603-E-2016

Note: Reference test setup 2.



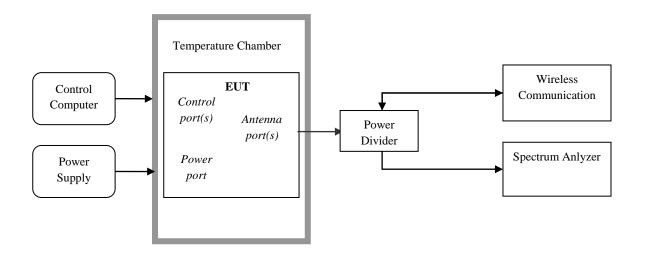
## 5.4 Test Setups

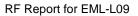
## **5.4.1** Test Setup 1





# **5.4.2** Test Setup 2



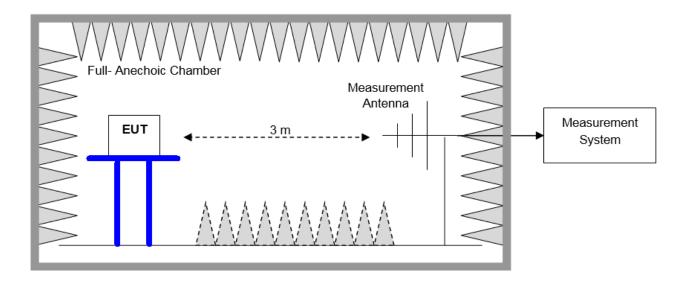




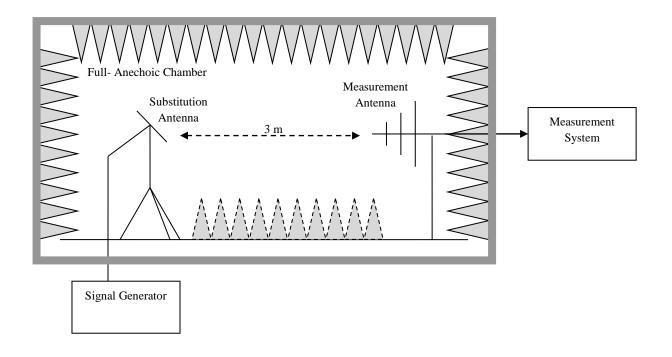
## **5.4.3** Test Setup 3

NOTE: Effective radiated power (ERP) and Equivalent Isotropic Radiated Power(EIRP) refers to the radiation power output of the EUT, assuming all emissions are radiated from half-wave dipole antennas.

## 5.4.3.1 Step 1: Pre-test



# 5.4.3.2 Step 2: Substitution method to verify the maximum ERP/EIRP





# 5.5 Test Conditions

Test Case		Test Condition	ns
Transmit	Average Power,	Test Env.	Ambient Climate & Rated Voltage
Output	Total	Test Setup	Test Setup 1
Power Data		RF Channels	L, M, H
		(TX)	(L= low channel, M= middle channel, H= high channel)
		Test Mode	LTE/TM1,LTE/TM2
	Average Power,	Test Env.	Ambient Climate & Rated Voltage
	Spectral Density	Test Setup	Test Setup 1
	(if required)	RF Channels	L, M, H
		(TX)	(L= low channel, M= middle channel, H= high channel)
		Test Mode	LTE/TM1,LTE/TM2
Peak-to-Aver	age Ratio	Test Env.	Ambient Climate & Rated Voltage
(if required)		Test Setup	Test Setup 1
		RF Channels	L, M, H
		(TX)	(L= low channel, M= middle channel, H= high channel)
		Test Mode	LTE/TM1,LTE/TM2
Modulation C	haracteristics	Test Env.	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels	M
		(TX)	(L= low channel, M= middle channel, H= high channel)
		Test Mode	LTE/TM1,LTE/TM2
Bandwidth	Occupied	Test Env.	Ambient Climate & Rated Voltage
	Bandwidth	Test Setup	Test Setup 1
		RF Channels	L, M, H
		(TX)	(L= low channel, M= middle channel, H= high channel)
		Test Mode	LTE/TM1,LTE/TM2
	Emission	Test Env.	Ambient Climate & Rated Voltage
	Bandwidth	Test Setup	Test Setup 1
	(if required)	RF Channels	L, M, H
		(TX)	(L= low channel, M= middle channel, H= high channel)
		Test Mode	LTE/TM1,LTE/TM2
Band Edges	Compliance	Test Env.	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels	L, H
		(TX)	(L= low channel, M= middle channel, H= high channel)
		Test Mode	LTE/TM1,LTE/TM2
Spurious Em	ission at Antenna	Test Env.	Ambient Climate & Rated Voltage
Terminals		Test Setup	Test Setup 1
		RF Channels	L, M, H
		(TX)	(L= low channel, M= middle channel, H= high channel)



Test Case	Test Condition	tions		
	Test Mode	LTE/TM1,LTE/TM2		
Field Strength of Spurious	Test Env.	Ambient Climate & Rated Voltage		
Radiation	Test Setup	Test Setup 3		
	Test Mode	LTE/TM1,LTE/TM2		
		NOTE: If applicable, the EUT conf. that has maximum power		
		density (based on the equivalent power level) is		
		selected.		
	RF Channels	L, M, H		
	(TX)	(L= low channel, M= middle channel, H= high channel)		
Frequency Stability	Test Env.	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage;		
		(2) VL, VN and VH of Rated Voltage at Ambient Climate.		
	Test Setup	Test Setup 2		
	RF Channels	L, M, H		
	(TX)	(L= low channel, M= middle channel, H= high channel)		
	Test Mode	LTE/TM1,LTE/TM2		

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# 6 Main Test Instruments

## 6.1 Current Test Project/Report

#### 6.1.1 Test Location 1:

This table gives a complete overview of the RF measurement equipment.

Devices used during the test described are marked  $\boxtimes$ 

Main	☑ Main Test Equipments( GSM/WCDMA/LTE test system)					
Marked	Equipment Name	Manufacturer	Model	Serial Number	Cal Date	Cal-Due
	DC Power Supply	KEITHLEY	2303	1342889	2018/10/24	2019/10/24
	DC Power Supply	KEITHLEY	2303	000500E	2018/05/21	2019/05/21
	DC Power Supply	KEITHLEY	2303	1288003	2018/12/21	2019/12/21
$\boxtimes$	DC Power Supply	KEITHLEY	2303	000381E	2018/05/21	2019/05/21
	DC Power Supply	KEITHLEY	2303	000510E	2018/05/21	2019/05/21
	DC Power Supply	KEITHLEY	2303	1342896	2018/10/24	2019/10/24
$\boxtimes$	Temperature Chamber	WEISS	WKL64	562460029400 10	2018/12/13	2019/12/13
	Universal Radio Communication Tester	R&S	CMW500	159302	2018/07/23	2019/07/23
	Universal Radio Communication Tester	R&S	CMW500	126854	2018/07/23	2019/07/23
	Universal Radio Communication Tester	R&S	CMW500	164698	2018/06/17	2019/06/17
	Universal Radio Communication Tester	R&S	CMU200	110932	2018/4/27	2019/4/27
	Universal Radio Communication Tester	R&S	CMU200	123299	2018/11/23	2019/11/23
	Universal Radio Communication Tester	R&S	CMU200	117341	2018/12/09	2019/12/09
	Signal Analyzer	R&S	FSQ31	200021	2018/7/23	2019/7/23
	Signal Analyzer	R&S	FSU26	201069	2018/11/02	2019/11/02
	Spectrum Analyzer	Agilent	N9030A	MY51380032	2018/07/23	2019/07/23
$\boxtimes$	Spectrum Analyzer	Agilent	N9030A	MY49431698	2018/07/23	2019/07/23
$\boxtimes$	Spectrum Analyzer	Keysight	N9040B	MY57212529	2018/06/28	2019/06/28
	Signal generator	Agilent	E8257D	MY51500314	2018/04/27	2019/04/27



$\boxtimes$	Signal generator	Agilent	E8257D	MY49281095	2018/07/23	2019/07/23
$\boxtimes$	Vector Signal Generator	R&S	SMU200A	104162	2018/07/23	2019/07/23
	Vector Signal Generator	R&S	SMW200A	103447	2018/05/31	2019/05/31

	Main Test Equipments( RSE test system)					
Marked	Equipment Name	Manufacturer	Model	Serial Number	Cal Date	Cal-Due
	Universal Radio Communication Tester	R&S	CMU200	117385	2018/05/08	2019/05/07
	Universal Radio Communication Tester	R&S	MT8821C	6261760791	2018/04/02	2019/04/01
$\boxtimes$	Spectrum analyzer	R&S	FSU3	200474	2018/01/20	2019/01/19
$\boxtimes$	Spectrum analyzer	R&S	FSU43	100144	2018/01/20	2019/01/19
	Trilog Broadband Antenna (30M~3GHz)	SCHWARZB ECK	VULB 9163	9163-490	2017/03/29	2019/03/28
$\boxtimes$	Trilog Broadband Antenna (30M~3GHz)	SCHWARZB ECK	VULB 9163	9163-521	2018/04/09	2020/04/08
	Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100304	2017/05/27	2019/05/26
$\boxtimes$	double ridged horn antenna ( 0.8G-18GHz)	R&S	HF907	100391	2017/7/20	2019/7/19
	Pyramidal Horn Antenna(18GHz-26.5 GHz)	ETS-Lindgre	3160-09	5140299	2017/07/20	2019/07/19
	Pyramidal Horn Antenna(18GHz-26.5 GHz)	ETS-Lindgre	3160-09	00206665	2018/4/21	2020/4/20
	Pyramidal Horn Antenna(26.5GHz-40 GHz)	ETS-Lindgre	3160-10	00205695	2018/04/20	2020/04/19
	Pyramidal Horn Antenna(26.5GHz-40 GHz)	ETS-Lindgre	3160-10	LM5947	2017/07/20	2019/07/19
$\boxtimes$	Measurement Software	R&S	EMC32 V8.40.0	/	/	/

#### 6.1.2 Sub-contracted Test Location 1:

Test Location 1:Main Test Equipments					
Equipment Name	Manufacturer	Model	Serial Number	Cal Date	Cal- Due
EMI Test Receiver&SA	Agilent	N9038A	N9038A	2018/8/30	2019/8/29
Loop Antenna	R&S	HFH2-Z2	HFH2-Z2	2018/5/30	2020/5/29
Bilog Antenna	TeseQ	CBL6112D	CBL6112D	2018/6/5	2019/6/4
LF Amplifier	Burgeon	BPA-530	BPA-530	2018/4/20	2019/4/19
Software Information					
Test Item	Software Name		Manufacturer		Version
RE	E3		AUDIX		6.2009-8-24(sporton)

# 7 Measurement Uncertainty

For a 95% confidence level (k = 2), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item		Extended Uncertainty	
Transmit Output Power	ransmit Output Power Power [dBm]		
Conducted			
RF Power Density, Conducted	RF Power Density, Conducted Power [dBm]		
Bandwidth	Magnitude [kHz]	200kHz: U=9.06kHz	
		1.4MHz: U=9.48kHz	
		3MHz: U=10.86kHz	
		5MHz: U=13.84kHz	
		10MHz: U=22.32kHz	
		15MHz: U=31.9kHz	
		20MHz: U=41.78kHz	
Band Edge Compliance	Disturbance Power [dBm]	U = 0.9  dB	
Spurious Emissions, Conducted	Disturbance Power [dBm]	20MHz~3.6GHz: U=0.88dB	
		3.6GHz~8.4GHz: U=1.08dB	
		8.4GHz~13.6GHz: U=1.24dB	
		13.6GHz~22GHz: U=1.34dB	
		22GHz~26.5GHz: U=1.36dB	
Field Strength of Spurious	ERP/EIRP [dBm]	For 3 m Chamber:	
Radiation		U = 5.94 dB (30 MHz to 3GHz)	
		U = 5.54 dB (3GHz to 18GHz)	
		U = 4.94 dB (18GHz to 26.5GHz)	
Frequency Stability	Frequency Accuracy [Hz]	800MHz: U=24.08Hz	
		900MHz: U=24.54Hz	
		1900MHz: U=34.7Hz	
		2100MHz: U=36.96Hz	



Test Item		Extended Uncertainty	
		2300MHz: U=39.24Hz	
		2500MHz: U=41.58Hz	
		2600MHz: U=42.74Hz	

**END**